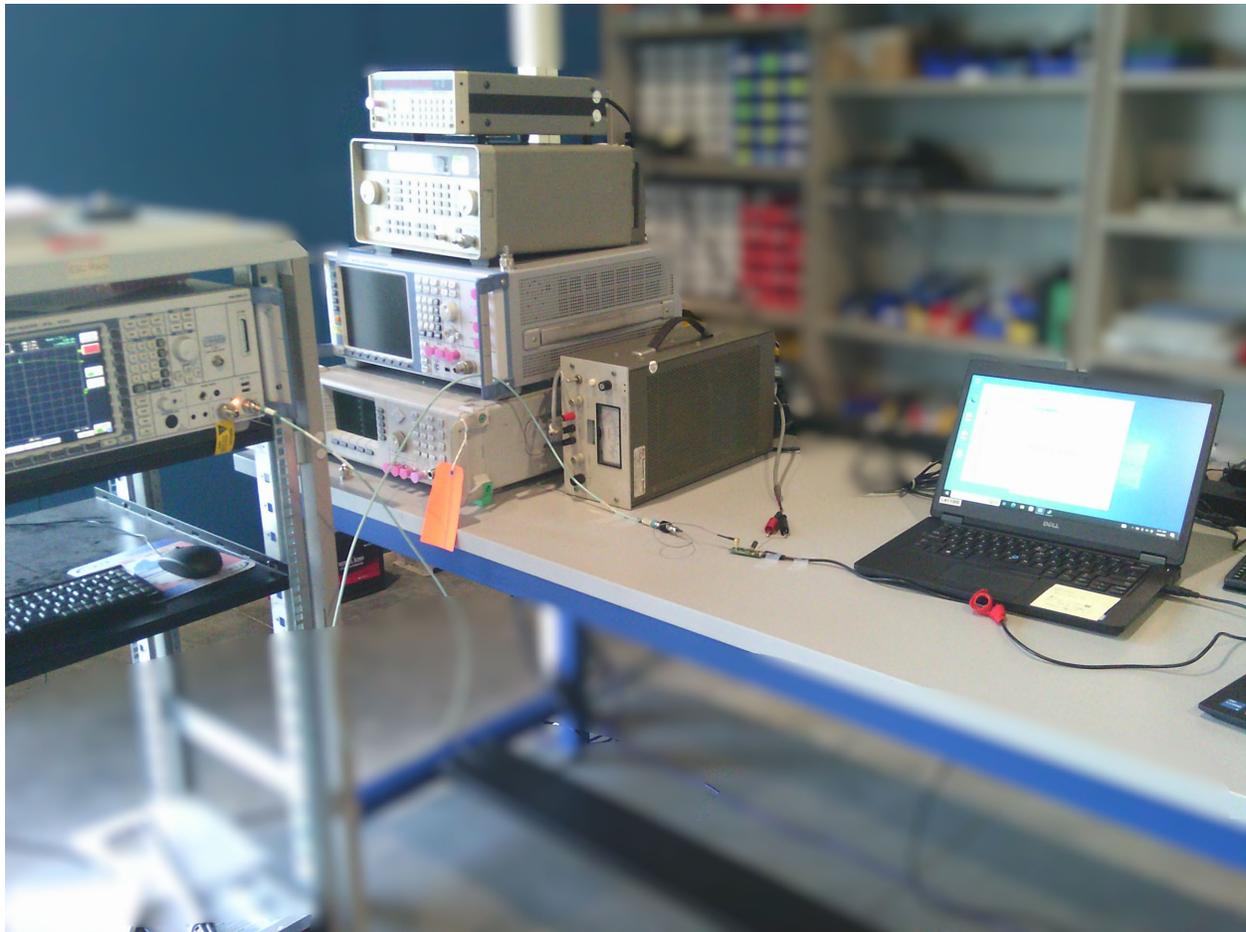
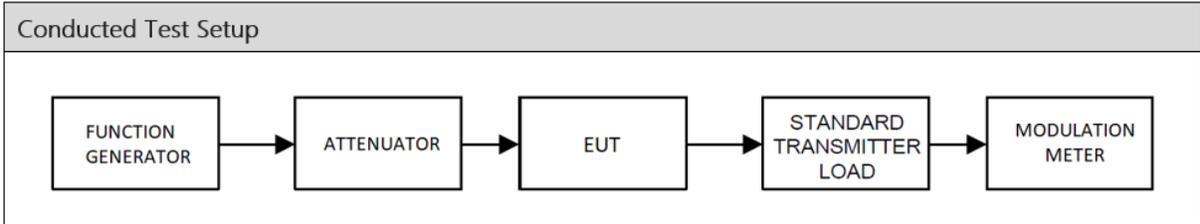


ANNEX B – Test Setup Photograph Exhibit

17875-24
Model: UT-136B
sFCC ID: AFJ381510
IC: 202D-381510

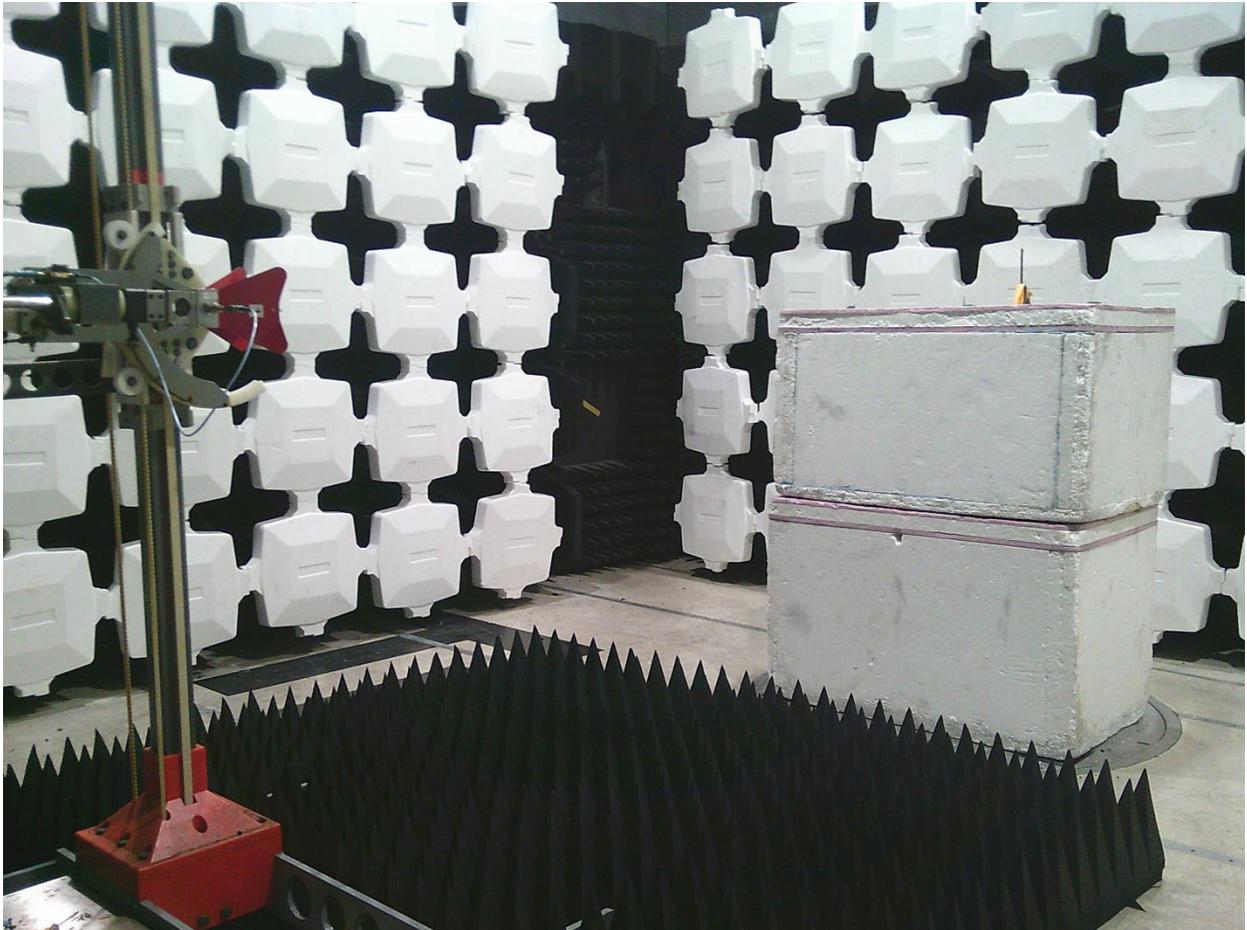
Conducted Test Setup



Radiated Testing, Table Setup #1

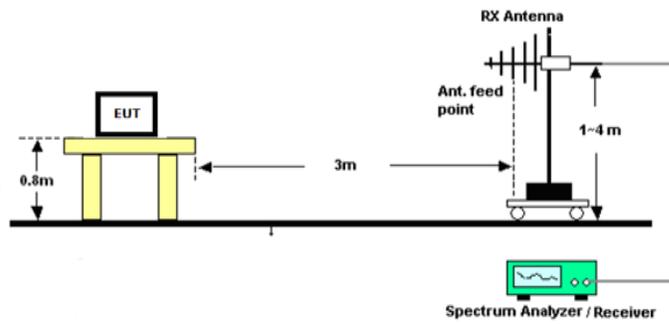


Radiated Testing, Table Setup #2



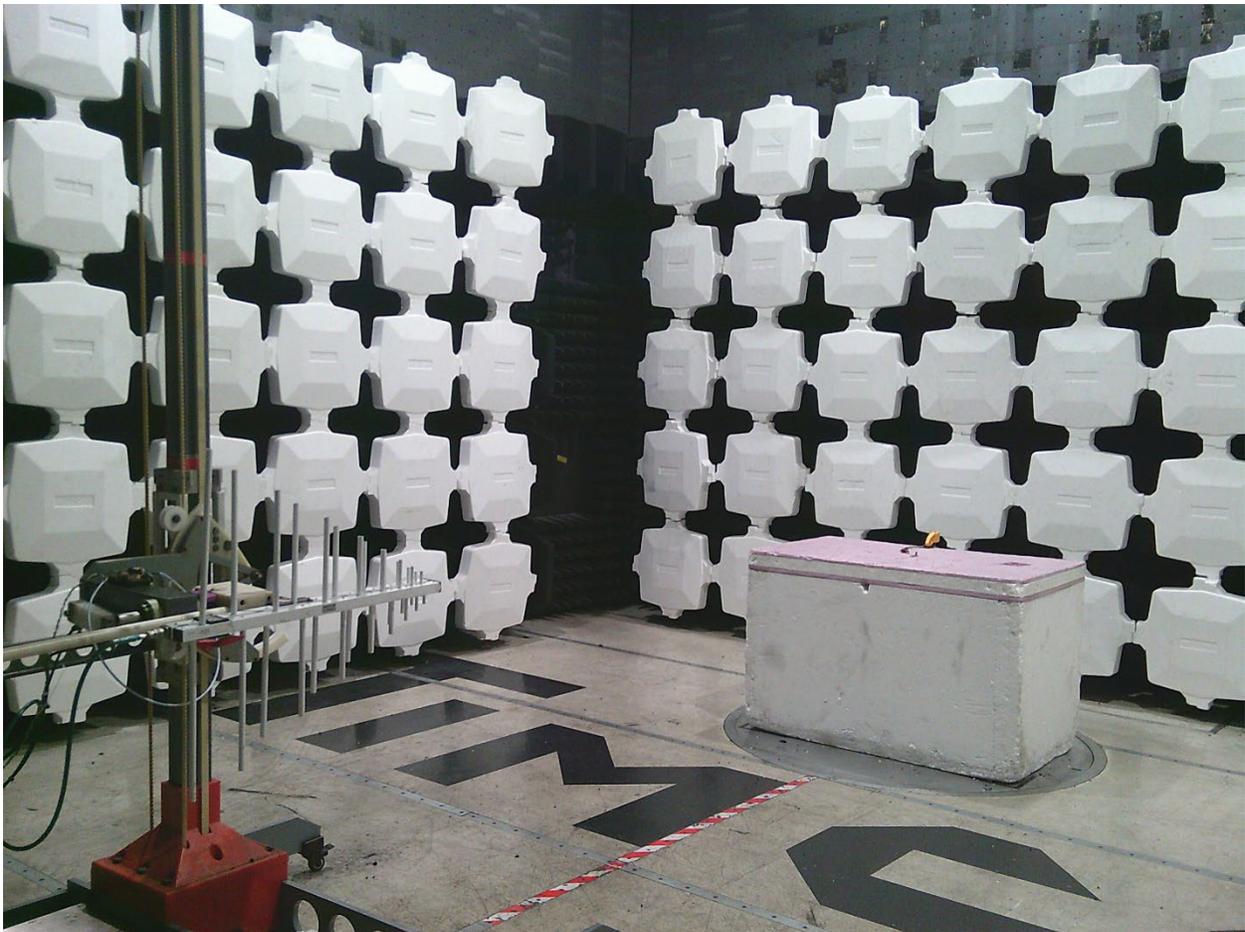
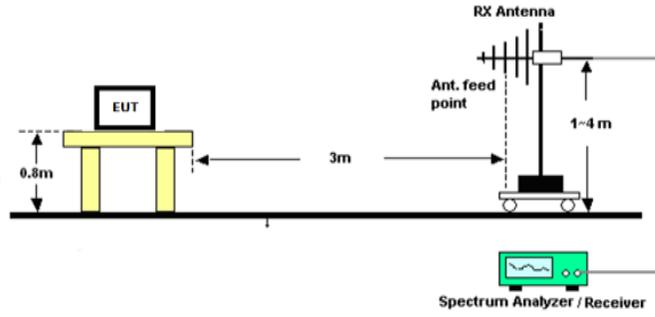
Radiated Testing, Below 1 GHz #1

Radiated Test Setup, 30 – 1000 MHz



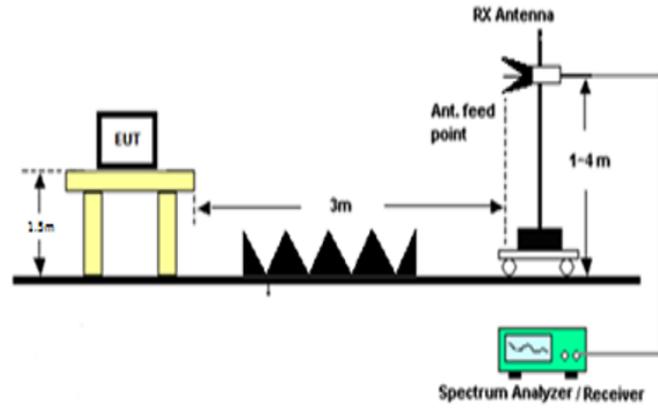
Radiated Testing, Below 1 GHz #2

Radiated Test Setup, 30 – 1000 MHz



Radiated Testing, Above 1 GHz #1

Radiated Test Setup, Above 1000 MHz



Radiated Testing, Above 1 GHz #2

